Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,787	SETHI ET AL.	
Examiner	Art Unit	
Chun-Kuan (Mike) Lee	2181	

SEARCHED						
Class	Subclass	Date	Examiner			
710	33	8/27/2007	CKL			

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
Updated EAST search: US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT Updated Inventor search utilizing eDan and EAST	8/27/2007	CKL		